TOSHIBA CMOS Digital Integrated Circuit Silicon Monolithic

TC74LVX273F,TC74LVX273FW,TC74LVX273FT

Octal D-Type Flip-Flop with Clear

Note: xxxFW (JEDEC SOP) is not available in Japan.

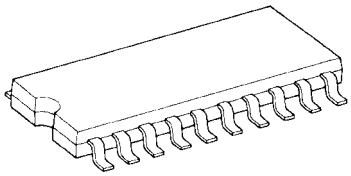
The TC74LVX273F/ FW/ FT is a high-speed CMOS octal D-flip flop fabricated with silicon gate CMOS technology. Designed for use in 3-V systems, it achieves high-speed operation while maintaining the CMOS low power dissipation.

This device is suitable for low-voltage and battery operated systems.

Information signals applied to D inputs are transferred to the Q outputs on the positive going edge of the clock pulse. When the $\overline{CLR}$ input is held low, the Q outputs are in the low logic level independent of the other inputs.

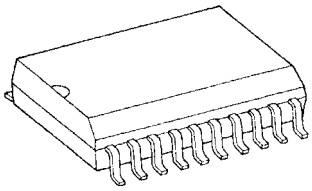
An input protection circuit ensures that 0 to 5.5V can be applied to the input pins without regard to the supply voltage. This device can be used to interface 5V to 3V systems and two supply systems such as battery back up. This circuit prevents device destruction due to mismatched supply and input voltages.

TC74LVX273F



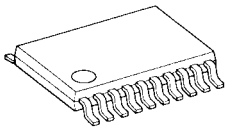
SOP20-P-300-1.27

TC74LVX273FW



SOL20-P-300-1.27

TC74LVX273FT



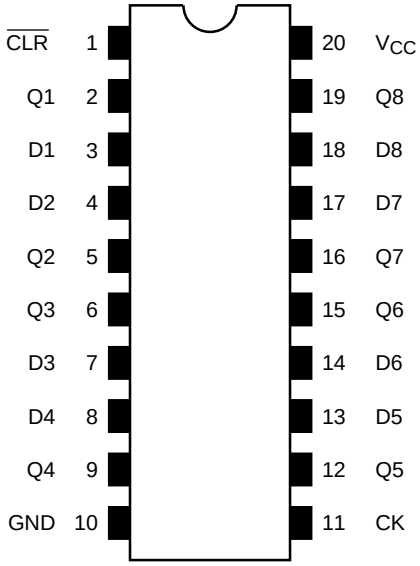
TSSOP20-P-0044-0.65

Weight
SOP20-P-300-1.27: 0.22 g (typ.)
SOL20-P-300-1.27: 0.46 g (typ.)
TSSOP20-P-0044-0.65: 0.08 g (typ.)

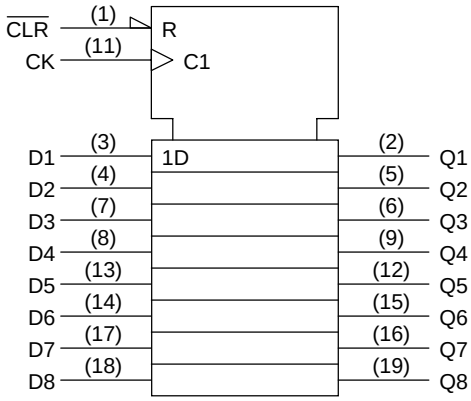
Features

- High-speed: f_{max} = 150 MHz (typ.) (V_{CC} = 3 V)
- Low power dissipation: I_{CC} = 4 μA (max) (Ta = 25°C)
- Input voltage level: V_{IL} = 0.8 V (max) (V_{CC} = 3 V)
  V_{IH} = 2.0 V (min) (V_{CC} = 3 V)
- Power-down protection provided on all inputs
- Balanced propagation delays: $t_{pLH} \approx t_{pHL}$
- Low niose: V_{OLP} = 0.8 V (max)
- Pin and function compatible with 74HC273

Pin Assignment (top view)



IEC Logic Symbol

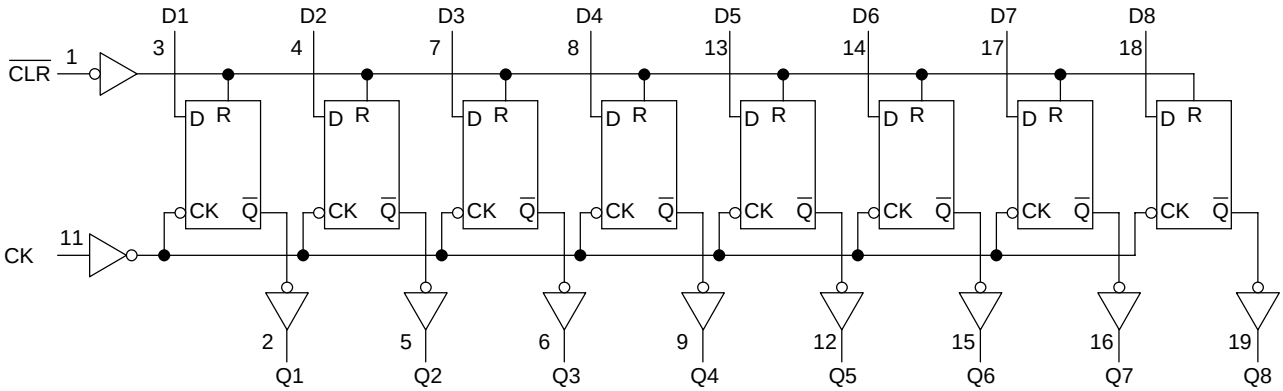


Truth Table

Inputs			Outputs	Function
$\overline{CLR}$	D	CK	Q	
L	X	X	L	Clear
H	L	↑	L	—
H	H	↑	H	—
H	X	↓	Qn	No change

X: Don't care

System Diagram



Maximum Ratings

Characteristics	Symbol	Rating	Unit
Supply voltage range	V_{CC}	−0.5 to 7.0	V
DC input voltage	V_{IN}	−0.5 to 7.0	V
DC output voltage	V_{OUT}	−0.5 to V_{CC} + 0.5	V
Input diode current	I_{IK}	−20	mA
Output diode current	I_{OK}	±20	mA
DC output current	I_{OUT}	±25	mA
DC V_{CC}/ground current	I_{CC}	±75	mA
Power dissipation	P_D	180	mW
Storage temperature	T_{stg}	−65 to 150	°C

Recommended Operating Conditions

Characteristics	Symbol	Rating	Unit
Supply voltage	V_{CC}	2.0 to 3.6	V
Input voltage	V_{IN}	0 to 5.5	V
Output voltage	V_{OUT}	0 to V_{CC}	V
Operating temperature	T_{opr}	−40 to 85	°C
Input rise and fall time	dt/dv	0 to 100	ns/V

Electrical Characteristics

DC Characteristics

Characteristics		Sym-bol	Test Condition			Ta = 25°C			Ta = −40 to 85°C		Unit
					V_{CC} (V)	Min	Typ.	Max	Min	Max	
Input voltage	H-level	V_{IH}	—		2.0	1.5	—	—	1.5	—	V
					3.0	2.0	—	—	2.0	—	
					3.6	2.4	—	—	2.4	—	
	L-level	V_{IL}	—		2.0	—	—	0.5	—	0.5	
					3.0	—	—	0.8	—	0.8	
					3.6	—	—	0.8	—	0.8	
Output voltage	H-level	V_{OH}	V_{IN} = V_{IH} or V_{IL}	I_{OH} = −50 μA	2.0	1.9	2.0	—	1.9	—	V
				I_{OH} = −50 μA	3.0	2.9	3.0	—	2.9	—	
				I_{OH} = −4 mA	3.0	2.58	—	—	2.48	—	
	L-level	V_{OL}	V_{IN} = V_{IH} or V_{IL}	I_{OL} = 50 μA	2.0	—	0	0.1	—	0.1	
				I_{OL} = 50 μA	3.0	—	0	0.1	—	0.1	
				I_{OL} = 4 mA	3.0	—	—	0.36	—	0.44	
Input leakage current		I_{IN}	V_{IN} = 5.5 V or GND		3.6	—	—	±0.1	—	±1.0	μA
Quiescent supply current		I_{CC}	V_{IN} = V_{CC} or GND		3.6	—	—	4.0	—	40.0	μA

Timing Requirements (input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Test Condition		Ta = 25°C	Ta = −40 to 85°C	Unit
			V_{CC} (V)	Limit	Limit	
Minimum pulse width (CK)	$t_{W(L)}$	—	2.7	8.0	9.5	ns
	$t_{W(H)}$		3.3 ± 0.3	5.5	6.5	
Minimum pulse width ($\overline{CLR}$)	$t_{W(L)}$	—	2.7	7.5	8.5	ns
			3.3 ± 0.3	5.0	6.0	
Minimum set-up time	t_s	—	2.7	8.0	9.5	ns
			3.3 ± 0.3	5.5	6.5	
Minimum hold time	t_h	—	2.7	1.0	1.0	ns
			3.3 ± 0.3	1.0	1.0	
Minimum removal time ($\overline{CLR}$)	t_{rem}	—	2.7	4.0	4.0	ns
			3.3 ± 0.3	2.5	2.5	

AC Characteristics (input: $t_r = t_f = 3$ ns)

Characteristics	Symbol	Test Condition			Ta = 25°C			Ta = −40 to 85°C		Unit
			V_{CC} (V)	C_L (pF)	Min	Typ.	Max	Min	Max	
Propagation delay time (CK-Q)	t_{pLH}	—	2.7	15	—	9.0	16.9	1.0	20.5	ns
				50	—	11.5	20.4	1.0	24.0	
	t_{pHL}		3.3 ± 0.3	15	—	7.1	11.0	1.0	13.0	
				50	—	9.6	14.5	1.0	16.5	
Propagation delay time ($\overline{CLR}$-Q)	t_{pHL}	—	2.7	15	—	9.3	17.6	1.0	20.5	ns
				50	—	11.8	21.1	1.0	24.0	
			3.3 ± 0.3	15	—	7.3	11.5	1.0	13.5	
				50	—	9.8	15.0	1.0	17.0	
Maximum clock frequency	f_{max}	—	2.7	15	55	110	—	45	—	MHz
				50	45	60	—	40	—	
			3.3 ± 0.3	15	95	150	—	80	—	
				50	60	90	—	50	—	
Output to output skew	t_{osLH}	(Note 1)	2.7	50	—	—	1.5	—	1.5	ns
	t_{osHL}		3.3 ± 0.3	50	—	—	1.5	—	1.5	
Input capacitance	C_{IN}	(Note 2)			—	4	10	—	10	pF
Power dissipation capacitance	C_{PD}	(Note 3)			—	31	—	—	—	pF

Note 1: Parameter guaranteed by design.
($t_{osLH} = |t_{pLHm} - t_{pLHn}|$, $t_{osHL} = |t_{pHLm} - t_{pHLn}|$)

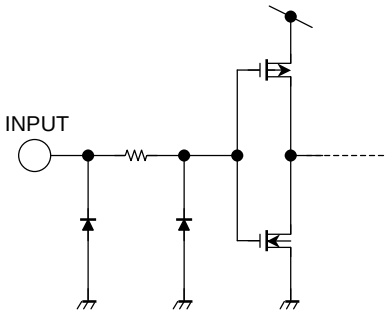
Note 2: Parameter guaranteed by design.

Note 3: C_{PD} is defined as the value of the internal equivalent capacitance which is calculated from the operating current consumption.
Average operating current can be obtained by the equation:
$I_{CC\ (opr)} = C_{PD} \cdot V_{CC} \cdot f_{IN} + I_{CC}/8$ (per F/F)
And the total C_{PD} when n pcs. of F/F operate can be gained by the following equation:
C_{PD} (total) = 22 + 9·n

Noise Characteristics (Ta = 25°C, input: $t_r = t_f = 3$ ns, $C_L = 50$ pF)

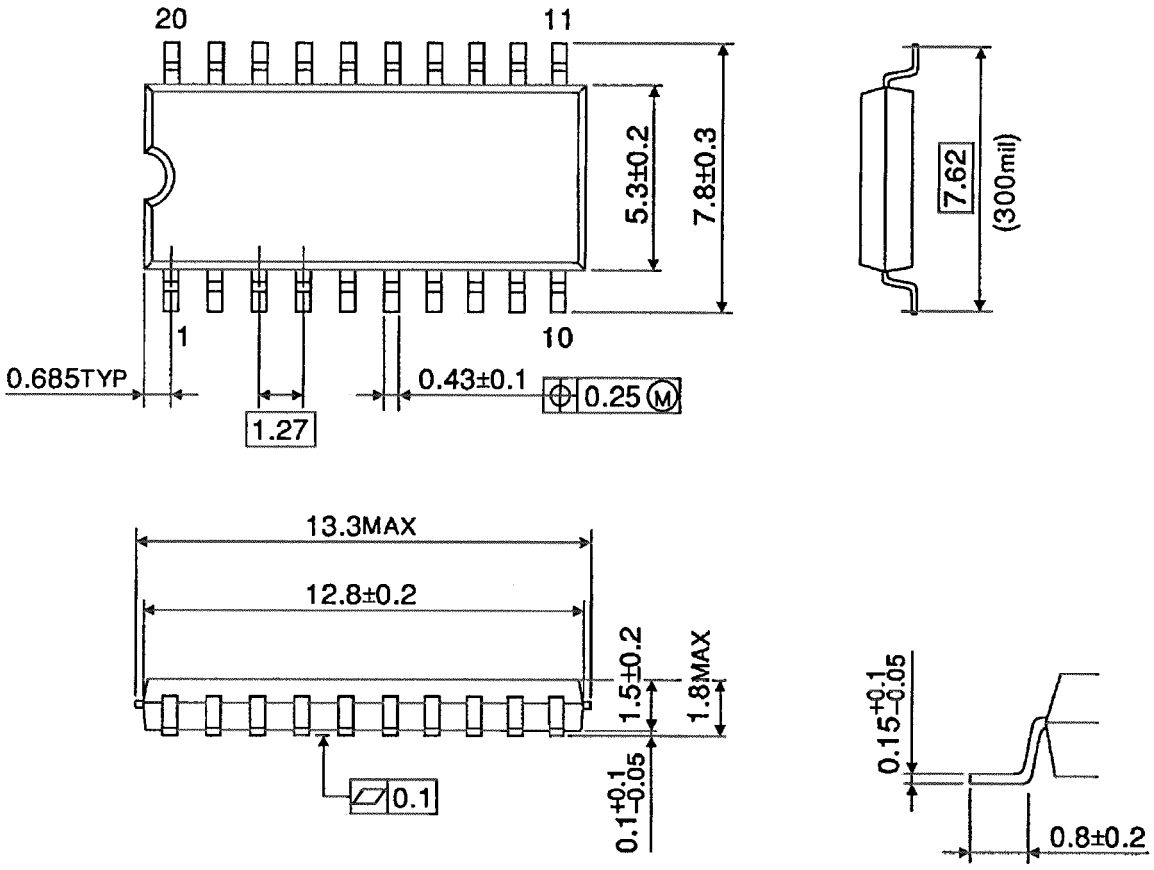
Characteristics		Symbol	Test Condition	Typ.	Limit	Unit
			V_{CC} (V)			
Quiet output maximum dynamic	V_{OL}	V_{OLP}	—	3.3	0.5	0.8	V
Quiet output minimum dynamic	V_{OL}	V_{OLV}	—	3.3	−0.5	−0.8	V
Minimum high level dynamic input voltage	V_{IH}	V_{IHD}	—	3.3	—	2.0	V
Maximum low level dynamic input voltage	V_{IL}	V_{ILD}	—	3.3	—	0.8	V

Input Equivalent Circuit



Package Dimensions

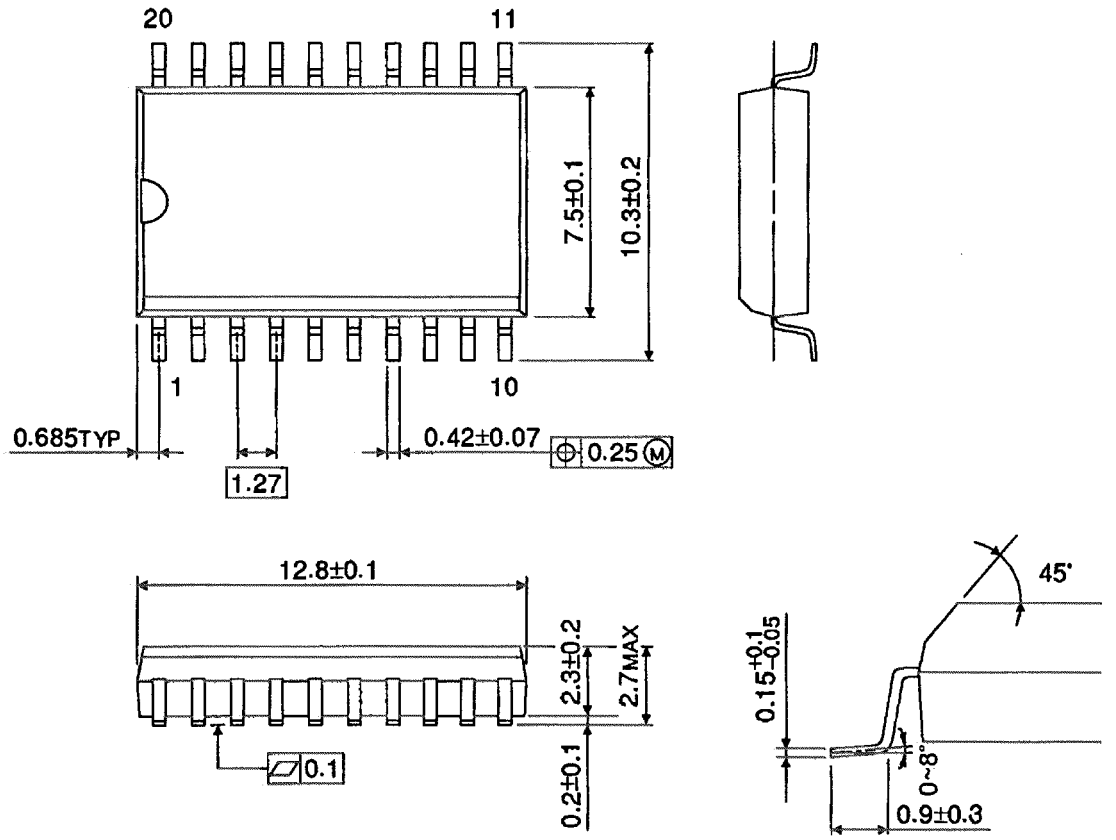
SOP20-P-300-1.27 Unit : mm



Weight: 0.22 g (typ.)

Package Dimensions

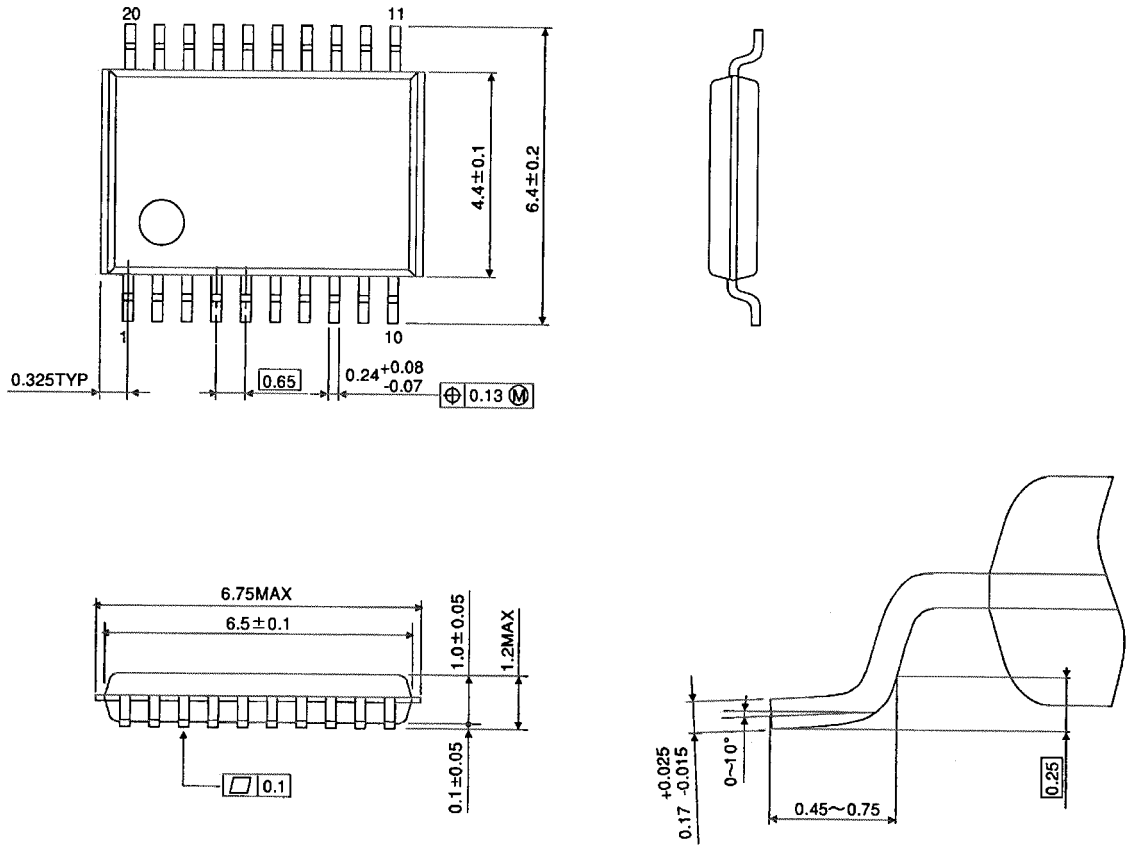
SOL20-P-300-1.27 Unit : mm



Weight: 0.46 g (typ.)

Package Dimensions

TSSOP20-P-0044-0.65 Unit : mm



Weight: 0.08 g (typ.)

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